

SPP02N60C3

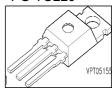
Cool MOS™ Power Transistor

Feature

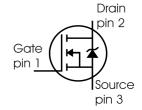
- New revolutionary high voltage technology
- Ultra low gate charge
- Periodic avalanche rated
- Extreme dv/dt rated
- Ultra low effective capacitances
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC⁰⁾ for target applications

V _{DS} @ T _{jmax}	650	٧
R _{DS(on)}	3	Ω
/ _D	1.8	Α





Туре	Package	Ordering Code	Marking
SPP02N60C3	PG-TO220	Q67040-S4392	02N60C3



Maximum Ratings

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Parameter	Symbol	Value	Unit
Continuous drain current	I_{D}		Α
$T_{\rm C}$ = 25 °C		1.8	
<i>T</i> _C = 100 °C		1.1	
Pulsed drain current, t_p limited by T_{jmax}	I _{D puls}	5.4	
Avalanche energy, single pulse	E _{AS}	50	mJ
$I_{\rm D}$ = 1.35 A, $V_{\rm DD}$ = 50 V			
Avalanche energy, repetitive t_{AR} limited by T_{jmax} ¹	E _{AR}	0.07	
$I_{\rm D}$ = 1.8 A, $V_{\rm DD}$ = 50 V			
Avalanche current, repetitive t_{AR} limited by T_{jmax}	I _{AR}	1.8	Α
Gate source voltage static	V_{GS}	±20	V
Gate source voltage AC (f >1Hz)	V _{GS}	±30	
Power dissipation, $T_{\rm C}$ = 25°C	P _{tot}	25	W
Operating and storage temperature	T _j , T _{stg}	-55 +150	°C
Reverse diode dv/dt ⁶⁾	dv/dt	15	V/ns





Maximum Ratings

Parameter	Symbol	Value	Unit
Drain Source voltage slope	d <i>v</i> /d <i>t</i>	50	V/ns
$V_{\rm DS}$ = 480 V, $I_{\rm D}$ = 1.8 A, $T_{\rm j}$ = 125 °C			

Thermal Characteristics

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Thermal resistance, junction - case	R _{thJC}	-	-	5	K/W
Thermal resistance, junction - ambient, leaded	R_{thJA}	-	-	62	
SMD version, device on PCB:	R _{thJA}				
@ min. footprint		_	-	62	
@ 6 cm ² cooling area ²⁾		-	35	-	
Soldering temperature, wavesoldering	T _{sold}	-	-	260	°C
1.6 mm (0.063 in.) from case for 10s ³⁾					

Electrical Characteristics, at Tj=25°C unless otherwise specified

Parameter	Symbol	Conditions		Values		Unit
			min.	typ.	max.	
Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0V, I _D =0.25mA	600	-	-	V
Drain-Source avalanche	V _{(BR)DS}	V _{GS} =0V, I _D =0.25A	-	700	-	
breakdown voltage						
Gate threshold voltage	V _{GS(th)}	I_{D} =80 μ A, V_{GS} = V_{DS}	2.1	3	3.9	
Zero gate voltage drain current	I _{DSS}	V _{DS} =600V, V _{GS} =0V,				μA
		<i>T</i> _j =25°C,	-	0.5	1	
		<i>T</i> _j =150°C	-	-	50	
Gate-source leakage current	I _{GSS}	V _{GS} =30V, V _{DS} =0V	-	-	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10V, I _D =1.1A,				Ω
		<i>T</i> _j =25°C	-	2.7	3	
		<i>T</i> _j =150°C	-	7.3	-	
Gate input resistance	R_{G}	f=1MHz, open Drain	-	9	-	



Electrical Characteristics, at $T_i = 25$ °C, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Transconductance	<i>g</i> fs	V _{DS} ≥2*I _D *R _{DS(on)max} ,	-	1.75	-	S
		I _D =1.1A				
Input capacitance	C _{iss}	V _{GS} =0V, V _{DS} =25V,	-	200	-	pF
Output capacitance	Coss	f=1MHz	-	90	-	
Reverse transfer capacitance	C _{rss}		-	4	-	
Effective output capacitance,4)		V _{GS} =0V,	-	8.1	-	pF
energy related	, ,	V _{DS} =0V to 480V				
Effective output capacitance,5)	C _{o(tr)}		-	15.7	-	
time related	, ,					
Turn-on delay time	t _{d(on)}	V _{DD} =350V, V _{GS} =0/10V,	-	6	-	ns
Rise time	t _r	$I_{\rm D}$ =1.8A, $R_{\rm G}$ =50 Ω	-	3	-	
Turn-off delay time	t _{d(off)}		-	68	70	
Fall time	<i>t</i> _f		-	12	30	1

Gate Charge Characteristics

_						
Gate to source charge	Q_{gs}	V _{DD} =420V, I _D =1.8A	-	1.6	-	nC
Gate to drain charge	Q _{gd}		-	3.8	-	
Gate charge total	Q_{g}	V _{DD} =420V, I _D =1.8A,	-	9.5	12.5	
		V _{GS} =0 to 10V				
Gate plateau voltage	V _(plateau)	V _{DD} =420V, I _D =1.8A	-	5.5	-	V

⁰J-STD20 and JESD22

¹Repetitve avalanche causes additional power losses that can be calculated as $P_{AV} = E_{AR} * f$.

²Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical without blown air.

³Soldering temperature for TO-263: 220°C, reflow

 $^{^4}C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

 $^{^5}C_{
m o(tr)}$ is a fixed capacitance that gives the same charging time as $C_{
m oss}$ while $V_{
m DS}$ is rising from 0 to 80% $V_{
m DSS}$.

 $^{^{6}}$ I_{SD}<=I_D, di/dt<=400A/us, V_{DClink}=400V, V_{peak}<V_{BR, DSS}, T_j<T_{j,max}. Identical low-side and high-side switch.



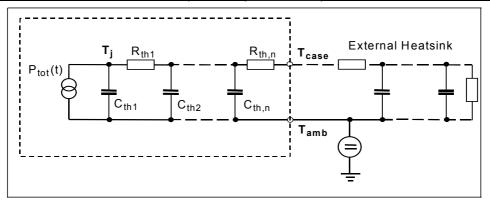


Electrical Characteristics, at T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Inverse diode continuous	IS	<i>T</i> _C =25°C	-	-	1.8	Α
forward current						
Inverse diode direct current,	/ _{SM}		-	-	5.4	
pulsed						
Inverse diode forward voltage	V _{SD}	V _{GS} =0V, I _F =I _S	-	1	1.2	V
Reverse recovery time	t _{rr}	V _R =420V, I _F =I _S ,	-	200	350	ns
Reverse recovery charge	Q _{rr}	d <i>i</i> _F /d <i>t</i> =100A/μs	-	1.3	-	μC
Peak reverse recovery current	/ _{rrm}		-	9	-	Α
Peak rate of fall of reverse	di _{rr} /dt		-	-	200	A/µs
recovery current						

Typical Transient Thermal Characteristics

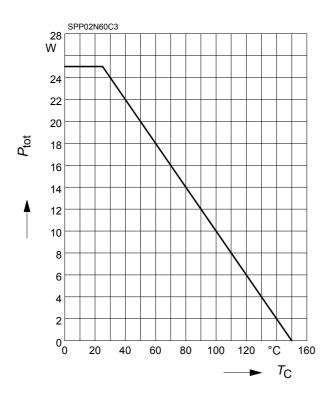
Symbol	Value	Unit	Symbol	Value	Unit
	typ.			typ.	
Thermal r	esistance	·	Thermal of	capacitance	
R _{th1}	0.1	K/W	C _{th1}	0.00002806	Ws/K
R _{th2}	0.184		C _{th2}	0.0001113	
R _{th3}	0.306		C _{th3}	0.0001679	
R _{th4}	1.207		C _{th4}	0.000547	
R _{th5}	0.974		C _{th5}	0.001388	
R _{th6}	0.251		C _{th6}	0.035	





1 Power dissipation

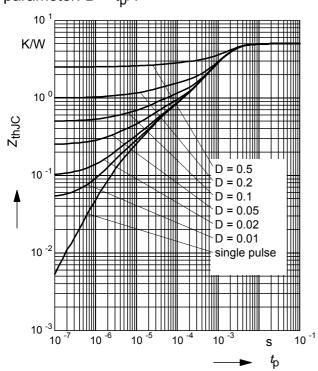
$$P_{\text{tot}} = f(T_{\text{C}})$$



3 Transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

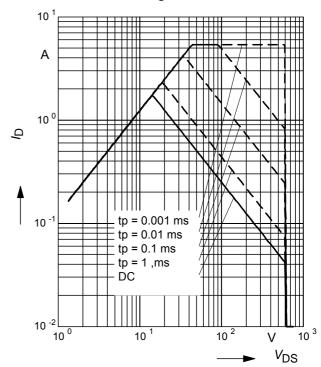
parameter: $D = t_p/T$



2 Safe operating area

$$I_{\mathsf{D}} = f(V_{\mathsf{DS}})$$

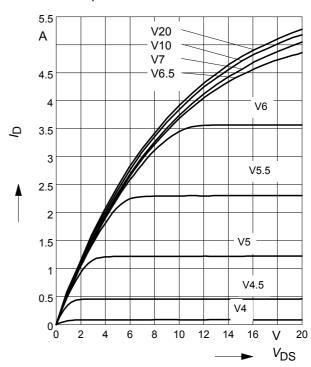
parameter : D = 0 , $T_C = 25$ °C



4 Typ. output characteristic

 $I_{D} = f(V_{DS}); T_{j}=25^{\circ}C$

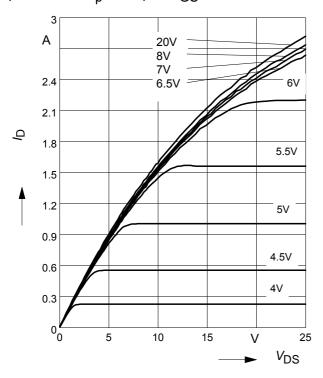
parameter: t_p = 10 μ s, V_{GS}





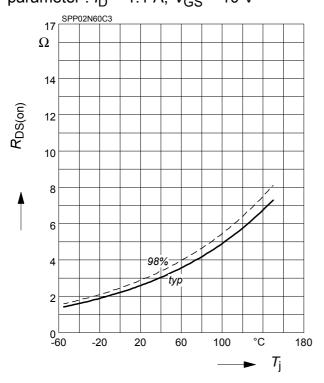
5 Typ. output characteristic

 $I_{\rm D} = f(V_{\rm DS}); T_{\rm j} = 150 ^{\circ} {\rm C}$ parameter: $t_{\rm p} = 10 \ \mu {\rm s}, \ V_{\rm GS}$



7 Drain-source on-state resistance

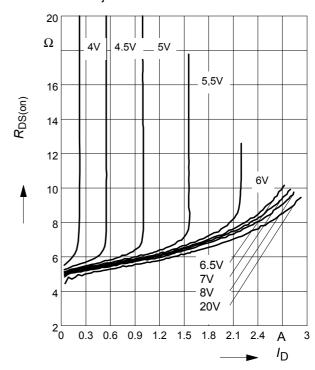
 $R_{\mathrm{DS(on)}} = f(T_{\mathrm{j}})$ parameter : $I_{\mathrm{D}} = 1.1 \,\mathrm{A}, \, V_{\mathrm{GS}} = 10 \,\mathrm{V}$



6 Typ. drain-source on resistance

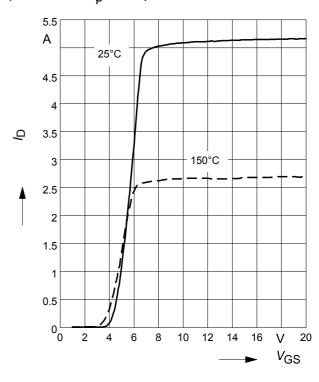
 $R_{\mathrm{DS(on)}} = f(I_{\mathrm{D}})$

parameter: T_i =150°C, V_{GS}



8 Typ. transfer characteristics

 $I_{\rm D}$ = $f(V_{\rm GS})$; $V_{\rm DS}$ $\geq 2 \times I_{\rm D} \times R_{\rm DS(on)max}$ parameter: $t_{\rm p}$ = 10 μ s

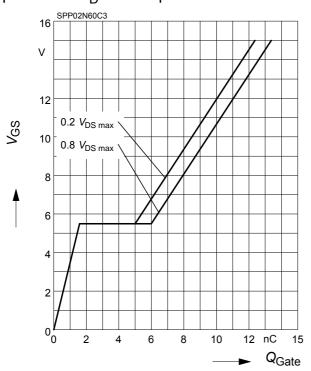




9 Typ. gate charge

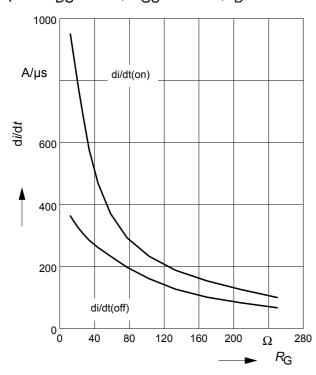
 $V_{GS} = f (Q_{Gate})$

parameter: I_D = 1.8 A pulsed



11 Typ. drain current slope

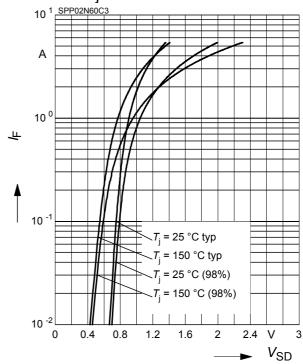
di/dt = f(R_G), inductive load, T_j = 125°C par.: V_{DS} =380V, V_{GS} =0/+13V, I_D =1.8A



10 Forward characteristics of body diode

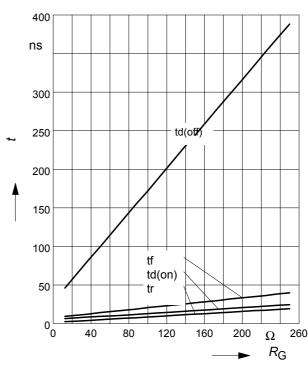
 $I_{\mathsf{F}} = f(\mathsf{V}_{\mathsf{SD}})$

parameter: T_i , $tp = 10 \mu s$



12 Typ. switching time

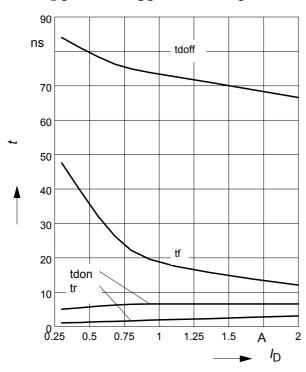
 $t = f(R_{\rm G})$, inductive load, $T_{\rm j}$ =125°C par.: $V_{\rm DS}$ =380V, $V_{\rm GS}$ =0/+13V, $I_{\rm D}$ =1.8 A





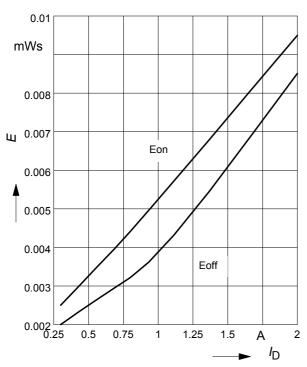
13 Typ. switching time

 $t = f(I_D)$, inductive load, T_j =125°C par.: V_{DS} =380V, V_{GS} =0/+13V, R_G =50 Ω



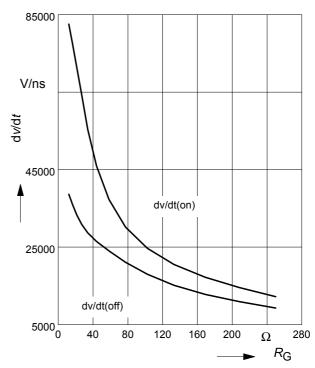
15 Typ. switching losses

 $E = f(I_D)$, inductive load, T_j =125°C par.: V_{DS} =380V, V_{GS} =0/+13V, R_G =50 Ω



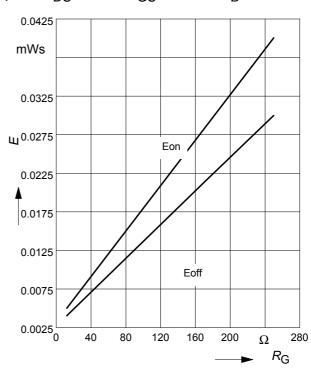
14 Typ. drain source voltage slope

 $dv/dt = f(R_G)$, inductive load, $T_j = 125$ °C par.: V_{DS} =380V, V_{GS} =0/+13V, I_D =1.8A



16 Typ. switching losses

 $E = f(R_G)$, inductive load, T_j =125°C par.: V_{DS} =380V, V_{GS} =0/+13V, I_D =1.8A

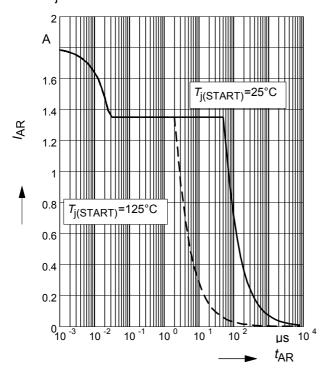




17 Avalanche SOA

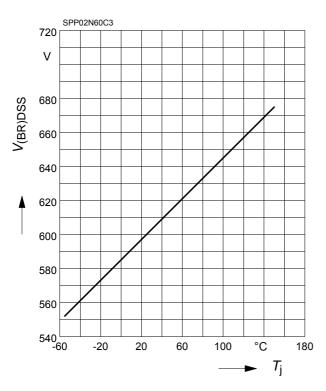
 $I_{AR} = f(t_{AR})$

par.: *T*_i ≤ 150 °C



19 Drain-source breakdown voltage

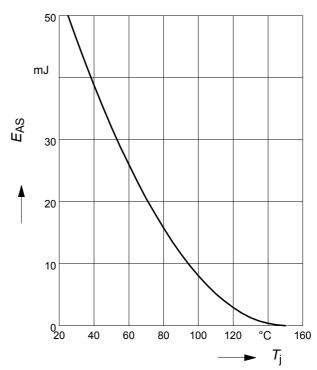
$$V_{(BR)DSS} = f(T_j)$$



18 Avalanche energy

 $E_{AS} = f(T_j)$

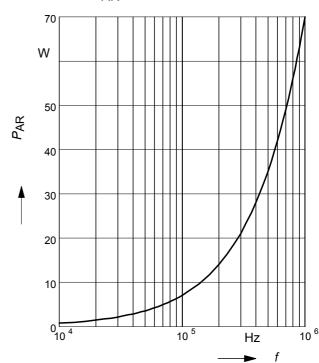
par.: $I_D = 1.35 \text{ A}, \ V_{DD} = 50 \text{ V}$



20 Avalanche power losses

 $P_{AR} = f(f)$

parameter: E_{AR} =0.07mJ

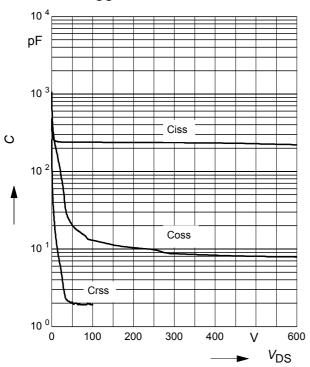




21 Typ. capacitances

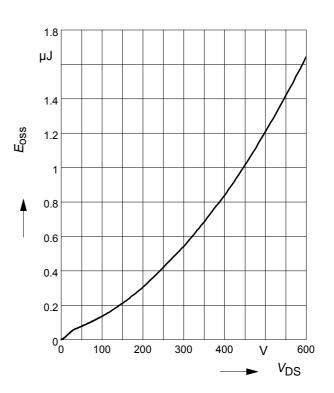
 $C = f(V_{DS})$

parameter: V_{GS} =0V, f=1 MHz

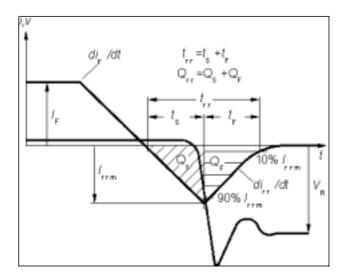


22 Typ. $C_{\rm OSS}$ stored energy

$$E_{\text{oss}} = f(V_{\text{DS}})$$

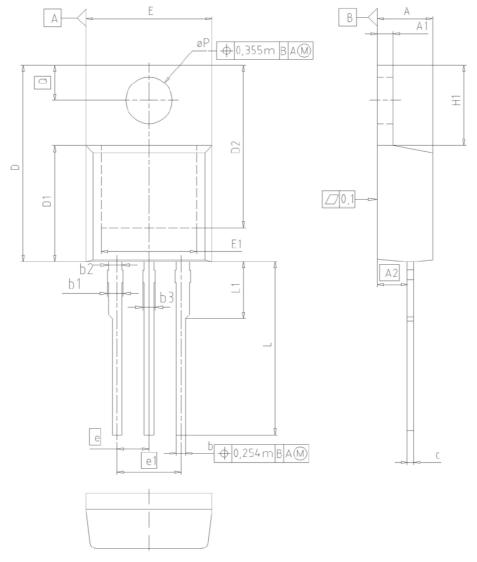


Definition of diodes switching characteristics





PG-TO220-3-1, PG-TO220-3-21: Outline



DIM	MILLI	METERS	INC	HES
DIM	MIN	MAX	MIN	MAX
Α	4.30	4.57	0.169	0.180
A1	1.17	1.40	0.046	0.055
A2	2.15	2.72	0.085	0.107
b	0.65	0.86	0.026	0.034
b1	0.95	1.40	0.037	0.055
b2	0.95	1.15	0.037	0.045
b3	0.65	1.15	0.026	0.045
С	0.33	0.60	0.013	0.024
D	14.81	15.95	0.583	0.628
D1	8.51	9.45	0.335	0.372
D2	12.19	13.10	0.480	0.516
E	9.70	10.36	0.382	0.408
E1	6.50	8.60	0.256	0.339
e	2	1.54	0.	100
e1	5	3.08	0.2	200
N		3		3
H1	5.90	6.90	0.232	0.272
L	13.00	14.00	0.512	0.551
L1	-	4.80	-	0.189
øΡ	3.60	3.89	0.142	0.153
Q	2.60	3.00	0.102	0.118

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